PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

RICHARD J. MARKLE ET AL

Scrial No.: 09/897,573

Filed: 7/2/2001

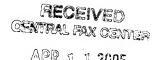
For: METHOD AND APPARATUS FOR DETERMINING GRID DIMENSIONS

USING SCATTEROMETRY

Group Art Unit: 2877

Examiner: Z. Smith

Atty. Dkt. No.: 2000.089400



BEST AVAILABLE COPY

DECLARATION UNDER 37 C.F.R. § 1.131 OF RICHARD J. MARKLE

- My name is Richard J. Markle. I have personal knowledge of the facts stated 1. herein.
- I am currently employed with Advanced Micro Devices, Inc. in Austin, Texas. I 2. am a named inventor on application Serial No. 09/897,573 entitled "Method and Apparatus for Determining Grid Dimensions Using Scatterometry."
- Attached as Exhibit A is a copy of the invention disclosure form I prepared in 3. Austin, Texas for the invention described in the above-referenced patent application. I prepared and signed the invention disclosure form on November 2, 2000, as indicated by the date adjacent my signature.
- The attached invention disclosure form was provided with internal tracking 4. number TT4355 by AMD's logal department, and it was sent to the law firm of Williams. Morgan & Amerson on or about November 10, 2000, with a request to prepare a United States patent application for the invention disclosed in the invention form.

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- I understand that willful false statements and the like so made are punishable by 5. fine or imprisonment, or both, and may jeopardize the validity of the application or any patent issuing thereon.
 - I declare under penalty of perjury that the foregoing is true and correct. 6.

Date 05